

Searched 	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10058036	TAKAGI ET AL.
	Examiner Parry, Chris	Art Unit 2623

Class	SubClass	Date	Examiner
725	38	04/05/2006	CLP
725	56-57	04/06/2006	CLP
UPDATED	ABOVE	07/05/2006	CLP

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SEE ATTACHED SEARCH HISTORY.	04/13/2006	CLP
CONSULTED EXAMINERS BRIAN YENKE AND VIC KOSTAK ON AREAS OF SEARCH IN CLASS 348.	04/07/2006	CLP
CONSULTED EXAMINERS SCOTT BELIVEAU, HAI TRAN, JASON SALCE, ANDREW KOENIG, AND REUBEN BROWN ON AREAS OF SEARCH IN CLASS 725.	04/12/2006	CLP
CONSULTED SPE CHRIS GRANT ON AREAS OF SEARCH.	04/12/2006	CLP
DOUBLE PATENTING SEARCH.	04/12/2006	CLP
UPDATED EAST SEARCH.	07/05/2006	CLP

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